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	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/649,258	BENCO ET AL.	
	Examiner	Art Unit	
_	Tu X. Nguyen	2618	

SEARCHED			
Class	Subclass	Date	Examiner
455	436	6/7/2007	TN
	422		
	417		
	445		
	527		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	,		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Search East	6/7/2007	TN